

<b>Notice of References Cited</b>	Application/Control No. 09/994,574	Applicant(s)/Patent Under Reexamination WHEELER ET AL.	
	Examiner Russell L. Guill	Art Unit 2123	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Internet pages from the Internet Archive Wayback Machine, www.archive.org, search for www.expressivesystems.com, February 8, 2001
	V	Yamagishi, Kunihiro.; Sekine, Masatoshi; "A multi-representational design data capture system", 1993, IEE 1993 Custom Integrated Circuits Conference
	W	IEEE Standard Hardware Description Language Based on the Verilog® Hardware Description Language, 1995, IEEE
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.